## Notice of References Cited Application/Control No. 10/791,507 Examiner Katarzyna Wyrozebski Applicant(s)/Patent Under Reexamination HITTLE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-34,880	05-1995	Salyer	106/660
*	В	US-4,513,053	04-1985	Chen et al.	428/221
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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